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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)				<b>Complete if Known</b>	
				Application Number	10/801,254
				Filing Date	March 16, 2004
				First Named Inventor	Farnworth et al.
				Group Art Unit	2133
				Examiner Name	G. Lamarre
Sheet	1	of	1	Attorney Docket Number	2269-2883.4US (96-0206.04/US)

U.S. PATENT DOCUMENTS					
Examiner Initials *	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number - Kind Code <sup>2</sup> (if known)			
		US-5,126,971	06/30/1992	Lin et al.	
		US- 5,301,143	04/05/1994	Ohri et al.	
		US- 5,402,018	03/28/1995	Koyanagi	
		US- 5,406,520	04/11/1995	Tay	
		US- 5,412,593	05/02/1995	Magel et al.	
		US- 5,430,679	07/04/1995	Hiltebeitel et al.	
		US- 5,455,798	10/03/1995	McClure	
		US- 5,491,864	02/13/1996	Phelan	
		US- 5,528,600	06/18/1996	El Ayat et al.	
		US- 5,550,394	08/27/1996	Sukegawa et al.	
		US- 5,566,107	10/15/1996	Gilliam	
		US- 5,576,999	11/19/1996	Kim et al.	
		US- 5,663,902	09/02/1997	Bennett et al.	
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FOREIGN PATENT DOCUMENTS						
Examiner Initials *	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> - Number <sup>4</sup> - Kind Code <sup>5</sup> (if known)				
		JP 06-069308	03/11/1994	NEC Corp		X
		JP 06-176597	06/24/1994	Toshiba Corp		X
		JP 06-069342	03/11/1994	Toshiba Corp		X
		JP 07-263563	10/13/1995	Toshiba Corp		X
		JP 06-012878	01/21/1994	Mitsubishi Electric Corp		X
		EP 0 218 852	04/22/1987	Siemens		

Examiner Signature		Date Considered	11/2/05
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

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Form PTO-1449 <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>			Docket Number (Optional) <b>2883.4US (96-0208.04/US)</b>		Application Number <b>Not yet assigned</b>	
			Applicant <b>Farnworth et al.</b>			
			Filing Date <b>March 16, 2004</b>		Group Art Unit <b>Unknown 2132</b>	

  

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,451,489	09/1995	Leedy			
	4,459,685	07/1984	Sud et al.			
	4,459,693	07/1984	Prang et al.			
	4,491,857	01/1985	McElroy			
	4,519,078	05/1985	Komonytsky			
	4,543,594	09/1985	Mohsen et al.			
	4,598,388	07/1986	Anderson			
	4,601,019	07/1986	Shah et al.			
	4,752,118	06/1988	Johnson			
	4,817,093	03/1989	Jacobs et al.			
	4,881,114	11/1989	Mohsen et al.			
	4,887,239	12/1989	Turner			

  

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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	0584739 A	03/1994	EP				
	0218851 A	04/1987	EP				

  

OTHER DOCUMENTS		(Including Author, Title, Date, Pertinent Pages, Etc.)
		NN8607696 (Test Circuit for Detecting and Measuring a Defect-Induced Increase in the Word Line Potential of Semiconductor Arrays; IBM Technical Disclosure Bulletin: Vol #29, pps. 696-698; July 1, 1986)

  

EXAMINER	DATE CONSIDERED <b>2/25/05</b>
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Form PTO-1449 <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>			Docket Number (Optional) <b>2883.4US (96-0206.04/US)</b>		Application Number <b>Not yet assigned</b>	
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,937,465	06/1990	Johnson et al.			
	4,939,694	07/1990	Eaton et al.			
	5,089,993	02/1992	Neal et al.			
	5,110,754	05/1992	Lowrey et al.			
	5,157,664	10/1992	Waite			
	5,241,496	08/1993	Lowrey et al.			
	5,257,229	10/1993	McClure et al.			
	5,278,839	01/1994	Matsumoto et al.			
	5,305,267	04/1994	Haraguchi et al.			
	5,324,681	06/1994	Lowrey et al.			
	5,331,196	07/1994	Lowrey et al.			

  

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						YES	NO

  

OTHER DOCUMENTS		(Including Author, Title, Date, Pertinent Pages, Etc.)

  

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5,355,340	10/1994	Coker et al.			
	5,422,850	06/1995	Sukegawa et al.			
	5,451,489	09/1995	Leedy			
	5,506,499	04/1996	Puar			
	5,539,349	07/1996	Roy			
	5,796,746	08/1998	Farnworth et al.			
	5,896,040	04/1999	Brannigan et al.			
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	6,009,536	12/1999	Rohwer			
	6,240,535	05/2001	Farnworth et al.			
	6,605,956	08/2003	Farnworth et al.			

### FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

### OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)


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